#### **Touch sensing controller (TSC)** 17

#### 17.1 Introduction

The touch sensing controller provides a simple solution for adding capacitive sensing functionality to any application. Capacitive sensing technology is able to detect finger presence near an electrode that is protected from direct touch by a dielectric (for example glass, plastic). The capacitive variation introduced by the finger (or any conductive object) is measured using a proven implementation based on a surface charge transfer acquisition principle.

The touch sensing controller is fully supported by the STMTouch touch sensing firmware library, which is free to use and allows touch sensing functionality to be implemented reliably in the end application.

#### 17.2 TSC main features

The touch sensing controller has the following main features:

- Proven and robust surface charge transfer acquisition principle
- Supports up to 18 capacitive sensing channels
- Up to 6 capacitive sensing channels can be acquired in parallel offering a very good response time
- Spread spectrum feature to improve system robustness in noisy environments
- Full hardware management of the charge transfer acquisition sequence
- Programmable charge transfer frequency
- Programmable sampling capacitor I/O pin
- Programmable channel I/O pin
- Programmable max count value to avoid long acquisition when a channel is faulty
- Dedicated end of acquisition and max count error flags with interrupt capability
- One sampling capacitor for up to 3 capacitive sensing channels to reduce the system components
- Compatible with proximity, touchkey, linear and rotary touch sensor implementation
- Designed to operate with STMTouch touch sensing firmware library

Note: The number of capacitive sensing channels is dependent on the size of the packages and subject to IO availability.

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# 17.3 TSC functional description

# 17.3.1 TSC block diagram

The block diagram of the touch sensing controller is shown in *Figure 100: TSC block diagram*.

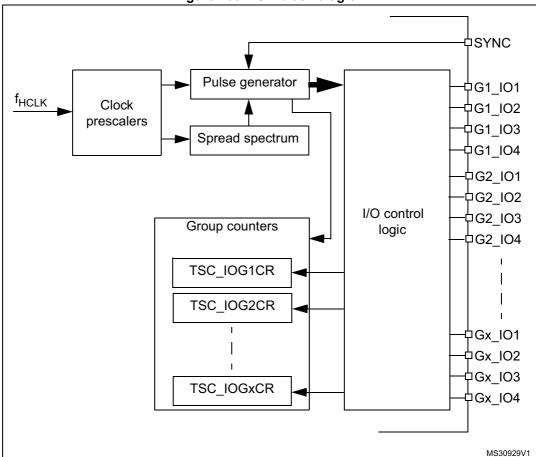


Figure 100. TSC block diagram

## 17.3.2 Surface charge transfer acquisition overview

The surface charge transfer acquisition is a proven, robust and efficient way to measure a capacitance. It uses a minimum number of external components to operate with a single ended electrode type. This acquisition is designed around an analog I/O group which is composed of up to four GPIOs (see *Figure 101*). Several analog I/O groups are available to allow the acquisition of several capacitive sensing channels simultaneously and to support a larger number of capacitive sensing channels. Within a same analog I/O group, the acquisition of the capacitive sensing channels is sequential.

One of the GPIOs is dedicated to the sampling capacitor  $C_S$ . Only one sampling capacitor I/O per analog I/O group must be enabled at a time.

The remaining GPIOs are dedicated to the electrodes and are commonly called channels. For some specific needs (such as proximity detection), it is possible to simultaneously enable more than one channel per analog I/O group.

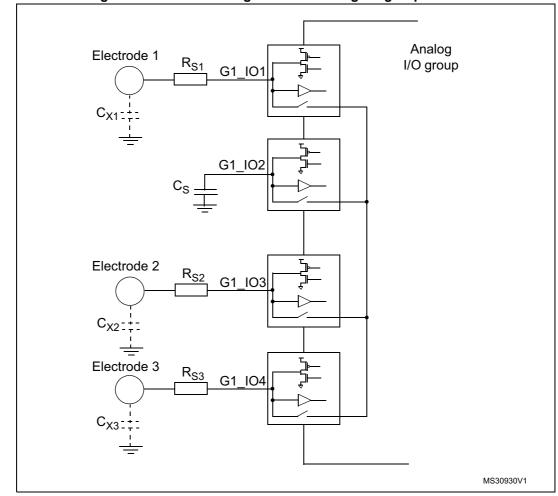


Figure 101. Surface charge transfer analog I/O group structure

Note:

Gx\_IOy where x is the analog I/O group number and y the GPIO number within the selected group.

The surface charge transfer acquisition principle consists of charging an electrode capacitance ( $C_X$ ) and transferring a part of the accumulated charge into a sampling capacitor ( $C_S$ ). This sequence is repeated until the voltage across  $C_S$  reaches a given threshold ( $V_{IH}$  in our case). The number of charge transfers required to reach the threshold is a direct representation of the size of the electrode capacitance.

The *Table 60* details the charge transfer acquisition sequence of the capacitive sensing channel 1. States 3 to 7 are repeated until the voltage across  $C_S$  reaches the given threshold. The same sequence applies to the acquisition of the other channels. The electrode serial resistor  $R_S$  improves the ESD immunity of the solution.



State	G1_IO1 (channel)	G1_IO2 (sampling)	G1_IO3 (channel)	G1_IO4 (channel)	State description
#1	Input floating with analog switch closed	Output open- drain low with analog switch closed	Input floating wit	th analog switch sed	Discharge all $C_X$ and $C_S$
#2		Input f	loating		Dead time
#3	Output push- pull high		Input floating		Charge C <sub>X1</sub>
#4		Input f	loating		Dead time
#5		th analog switch sed	Input f	Charge transfer from C <sub>X1</sub> to C <sub>S</sub>	
#6		Input f	loating		Dead time
#7		Input f	loating		Measure C <sub>S</sub> voltage

Table 60. Acquisition sequence summary

The voltage variation over the time on the sampling capacitor C<sub>S</sub> is detailed below:

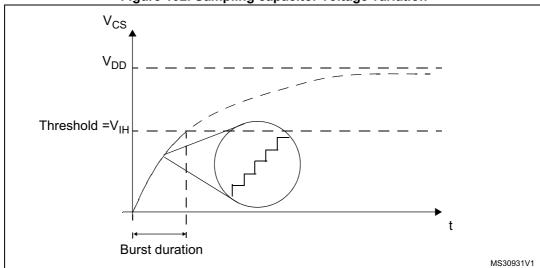


Figure 102. Sampling capacitor voltage variation

### 17.3.3 Reset and clocks

The TSC clock source is the AHB clock (HCLK). Two programmable prescalers are used to generate the pulse generator and the spread spectrum internal clocks:

- The pulse generator clock (PGCLK) is defined using the PGPSC[2:0] bits of the TSC\_CR register
- The spread spectrum clock (SSCLK) is defined using the SSPSC bit of the TSC\_CR register

The Reset and Clock Controller (RCC) provides dedicated bits to enable the touch sensing controller clock and to reset this peripheral. For more information, refer to Section 8: Reset and clock control (RCC).



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#### 17.3.4 Charge transfer acquisition sequence

An example of a charge transfer acquisition sequence is detailed in *Figure 103*.

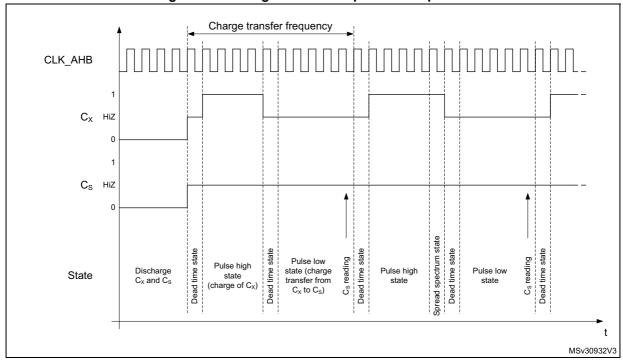


Figure 103. Charge transfer acquisition sequence

For higher flexibility, the charge transfer frequency is fully configurable. Both the pulse high state (charge of  $C_X$ ) and the pulse low state (transfer of charge from  $C_X$  to  $C_S$ ) duration can be defined using the CTPH[3:0] and CTPL[3:0] bits in the TSC\_CR register. The standard range for the pulse high and low states duration is 500 ns to 2 µs. To ensure a correct measurement of the electrode capacitance, the pulse high state duration must be set to ensure that C<sub>X</sub> is always fully charged.

A dead time where both the sampling capacitor I/O and the channel I/O are in input floating state is inserted between the pulse high and low states to ensure an optimum charge transfer acquisition sequence. This state duration is 2 periods of HCLK.

At the end of the pulse high state and if the spread spectrum feature is enabled, a variable number of periods of the SSCLK clock are added.

The reading of the sampling capacitor I/O, to determine if the voltage across C<sub>S</sub> has reached the given threshold, is performed at the end of the pulse low state.

Note:

The following TSC control register configurations are forbidden:

- bits PGPSC are set to '000' and bits CTPL are set to '0000'
- bits PGPSC are set to '000' and bits CTPL are set to '0001'
- bits PGPSC are set to '001' and bits CTPL are set to '0000'

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## 17.3.5 Spread spectrum feature

The spread spectrum feature allows to generate a variation of the charge transfer frequency. This is done to improve the robustness of the charge transfer acquisition in noisy environments and also to reduce the induced emission. The maximum frequency variation is in the range of 10% to 50% of the nominal charge transfer period. For instance, for a nominal charge transfer frequency of 250 kHz (4  $\mu$ s), the typical spread spectrum deviation is 10% (400 ns) which leads to a minimum charge transfer frequency of ~227 kHz.

In practice, the spread spectrum consists of adding a variable number of SSCLK periods to the pulse high state using the principle shown below:

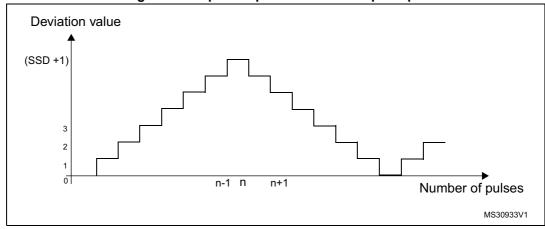


Figure 104. Spread spectrum variation principle

The table below details the maximum frequency deviation with different HCLK settings:

f <sub>HCLK</sub>	Spread spectrum step	Maximum spread spectrum deviation
24 MHz	41.6 ns	10666.6 ns
48 MHz	20.8 ns	5333.3 ns

Table 61. Spread spectrum deviation versus AHB clock frequency

The spread spectrum feature can be disabled/enabled using the SSE bit in the TSC\_CR register. The frequency deviation is also configurable to accommodate the device HCLK clock frequency and the selected charge transfer frequency through the SSPSC and SSD[6:0] bits in the TSC\_CR register.

### 17.3.6 Max count error

The max count error prevents long acquisition times resulting from a faulty capacitive sensing channel. It consists of specifying a maximum count value for the analog I/O group counters. This maximum count value is specified using the MCV[2:0] bits in the TSC\_CR register. As soon as an acquisition group counter reaches this maximum value, the ongoing acquisition is stopped and the end of acquisition (EOAF bit) and max count error (MCEF bit) flags are both set. An interrupt can also be generated if the corresponding end of acquisition (EOAIE bit) or/and max count error (MCEIE bit) interrupt enable bits are set.



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# 17.3.7 Sampling capacitor I/O and channel I/O mode selection

To allow the GPIOs to be controlled by the touch sensing controller, the corresponding alternate function must be enabled through the standard GPIO registers and the GPIOxAFR registers.

The GPIOs modes controlled by the TSC are defined using the TSC\_IOSCR and TSC\_IOCCR register.

When there is no ongoing acquisition, all the I/Os controlled by the touch sensing controller are in default state. While an acquisition is ongoing, only unused I/Os (neither defined as sampling capacitor I/O nor as channel I/O) are in default state. The IODEF bit in the TSC\_CR register defines the configuration of the I/Os which are in default state. The table below summarizes the configuration of the I/O depending on its mode.

10010 02	in C State as	conding on ite inc		Talas
IODEF bit	Acquisition status	Unused I/O mode	Channel I/O mode	Sampling capacitor I/O mode
0 (output push-pull low)	No	Output push-pull low	Output push-pull low	Output push-pull low
0 (output push-pull low)	Ongoing	Output push-pull low	-	-
1 (input floating)	No	Input floating	Input floating	Input floating
1 (input floating)	Ongoing	Input floating	-	-

Table 62. I/O state depending on its mode and IODEF bit value

#### Unused I/O mode

An unused I/O corresponds to a GPIO controlled by the TSC peripheral but not defined as an electrode I/O nor as a sampling capacitor I/O.

Sampling capacitor I/O mode

To allow the control of the sampling capacitor I/O by the TSC peripheral, the corresponding GPIO must be first set to alternate output open drain mode and then the corresponding Gx\_IOy bit in the TSC\_IOSCR register must be set.

Only one sampling capacitor per analog I/O group must be enabled at a time.

Channel I/O mode

To allow the control of the channel I/O by the TSC peripheral, the corresponding GPIO must be first set to alternate output push-pull mode and the corresponding Gx\_IOy bit in the TSC\_IOCCR register must be set.

For proximity detection where a higher equivalent electrode surface is required or to speed-up the acquisition process, it is possible to enable and simultaneously acquire several channels belonging to the same analog I/O group.

Note:

During the acquisition phase and even if the TSC peripheral alternate function is not enabled, as soon as the TSC\_IOSCR or TSC\_IOCCR bit is set, the corresponding GPIO analog switch is automatically controlled by the touch sensing controller.

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## 17.3.8 Acquisition mode

The touch sensing controller offers two acquisition modes:

- Normal acquisition mode: the acquisition starts as soon as the START bit in the TSC CR register is set.
- Synchronized acquisition mode: the acquisition is enabled by setting the START bit in the TSC\_CR register but only starts upon the detection of a falling edge or a rising edge and high level on the SYNC input pin. This mode is useful for synchronizing the capacitive sensing channels acquisition with an external signal without additional CPU load.

The GxE bits in the TSC\_IOGCSR registers specify which analog I/O groups are enabled (corresponding counter is counting). The  $C_S$  voltage of a disabled analog I/O group is not monitored and this group does not participate in the triggering of the end of acquisition flag. However, if the disabled analog I/O group contains some channels, they are pulsed.

When the  $C_S$  voltage of an enabled analog I/O group reaches the given threshold, the corresponding GxS bit of the TSC\_IOGCSR register is set. When the acquisition of all enabled analog I/O groups is complete (all GxS bits of all enabled analog I/O groups are set), the EOAF flag in the TSC\_ISR register is set. An interrupt request is generated if the EOAIE bit in the TSC\_IER register is set.

In the case that a max count error is detected, the ongoing acquisition is stopped and both the EOAF and MCEF flags in the TSC\_ISR register are set. Interrupt requests can be generated for both events if the corresponding bits (EOAIE and MCEIE bits of the TSCIER register) are set. Note that when the max count error is detected the remaining GxS bits in the enabled analog I/O groups are not set.

To clear the interrupt flags, the corresponding EOAIC and MCEIC bits in the TSC\_ICR register must be set.

The analog I/O group counters are cleared when a new acquisition is started. They are updated with the number of charge transfer cycles generated on the corresponding channel(s) upon the completion of the acquisition.

# 17.3.9 I/O hysteresis and analog switch control

In order to offer a higher flexibility, the touch sensing controller also allows to take the control of the Schmitt trigger hysteresis and analog switch of each Gx\_IOy. This control is available whatever the I/O control mode is (controlled by standard GPIO registers or other peripherals) assuming that the touch sensing controller is enabled. This may be useful to perform a different acquisition sequence or for other purposes.

In order to improve the system immunity, the Schmitt trigger hysteresis of the GPIOs controlled by the TSC must be disabled by resetting the corresponding Gx\_IOy bit in the TSC\_IOHCR register.



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# 17.4 TSC low-power modes

Table 63. Effect of low-power modes on TSC

Mode	Description
Sleep	No effect TSC interrupts cause the device to exit Sleep mode.
Stop	TSC registers are frozen
Standby	The TSC stops its operation until the Stop or Standby mode is exited.

# 17.5 TSC interrupts

Table 64. Interrupt control bits

Interrupt event	Enable control bit	Event flag	Clear flag bit	Exit the Sleep mode	Exit the Stop mode	Exit the Standby mode
End of acquisition	EOAIE	EOAIF	EOAIC	Yes	No	No
Max count error	MCEIE	MCEIF	MCEIC	Yes	No	No

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# 17.6 TSC registers

Refer to Section 1.2 on page 43 of the reference manual for a list of abbreviations used in register descriptions.

The peripheral registers can be accessed by words (32-bit).

# 17.6.1 TSC control register (TSC\_CR)

Address offset: 0x00

Reset value: 0x0000 0000

31	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16
	CTPI	H[3:0]			CTPI	L[3:0]					SSD[6:0]				SSE
rw	rw	rw	rw	rw	rw	rw	rw	rw	rw	rw	rw	rw	rw	rw	rw
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
SSPSC	Р	GPSC[2:	0]	Res.	Res.	Res.	Res.		MCV[2:0]		IODEF	SYNC POL	AM	START	TSCE
rw	rw	rw	rw					rw	rw	rw	rw	rw	rw	rw	rw

### Bits 31:28 CTPH[3:0]: Charge transfer pulse high

These bits are set and cleared by software. They define the duration of the high state of the charge transfer pulse (charge of  $C_X$ ).

0000: 1x t<sub>PGCLK</sub> 0001: 2x t<sub>PGCLK</sub> ...

1111: 16x t<sub>PGCLK</sub>

Note: These bits must not be modified when an acquisition is ongoing.

#### Bits 27:24 CTPL[3:0]: Charge transfer pulse low

These bits are set and cleared by software. They define the duration of the low state of the charge transfer pulse (transfer of charge from  $C_X$  to  $C_S$ ).

0000: 1x t<sub>PGCLK</sub> 0001: 2x t<sub>PGCLK</sub> ... 1111: 16x t<sub>PGCLK</sub>

Note: These bits must not be modified when an acquisition is ongoing.

Note: Some configurations are forbidden. Refer to the Section 17.3.4: Charge transfer

acquisition sequence for details.

### Bits 23:17 SSD[6:0]: Spread spectrum deviation

These bits are set and cleared by software. They define the spread spectrum deviation which consists in adding a variable number of periods of the SSCLK clock to the charge transfer pulse high state.

0000000: 1x t<sub>SSCLK</sub> 0000001: 2x t<sub>SSCLK</sub> ...

1111111: 128x t<sub>SSCLK</sub>

Note: These bits must not be modified when an acquisition is ongoing.

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### Bit 16 SSE: Spread spectrum enable

This bit is set and cleared by software to enable/disable the spread spectrum feature.

- 0: Spread spectrum disabled
- 1: Spread spectrum enabled

Note: This bit must not be modified when an acquisition is ongoing.

#### Bit 15 SSPSC: Spread spectrum prescaler

This bit is set and cleared by software. It selects the AHB clock divider used to generate the spread spectrum clock (SSCLK).

0: f<sub>HCLK</sub> 1: f<sub>HCLK</sub> /2

Note: This bit must not be modified when an acquisition is ongoing.

#### Bits 14:12 **PGPSC[2:0]**: Pulse generator prescaler

These bits are set and cleared by software. They select the AHB clock divider used to generate the pulse generator clock (PGCLK).

000: f<sub>HCLK</sub> /2 011: f<sub>HCLK</sub> /2 010: f<sub>HCLK</sub> /4 011: f<sub>HCLK</sub> /8 100: f<sub>HCLK</sub> /16 101: f<sub>HCLK</sub> /32 110: f<sub>HCLK</sub> /64 111: f<sub>HCLK</sub> /128

Note: These bits must not be modified when an acquisition is ongoing.

Note: Some configurations are forbidden. Refer to the Section 17.3.4: Charge transfer acquisition sequence for details.

#### Bits 11:8 Reserved, must be kept at reset value.

#### Bits 7:5 MCV[2:0]: Max count value

These bits are set and cleared by software. They define the maximum number of charge transfer pulses that can be generated before a max count error is generated.

000: 255 001: 511 010: 1023 011: 2047 100: 4095 101: 8191 110: 16383 111: reserved

Note: These bits must not be modified when an acquisition is ongoing.

### Bit 4 IODEF: I/O Default mode

This bit is set and cleared by software. It defines the configuration of all the TSC I/Os when there is no ongoing acquisition. When there is an ongoing acquisition, it defines the configuration of all unused I/Os (not defined as sampling capacitor I/O or as channel I/O).

0: I/Os are forced to output push-pull low

1: I/Os are in input floating

Note: This bit must not be modified when an acquisition is ongoing.

#### Bit 3 SYNCPOL: Synchronization pin polarity

This bit is set and cleared by software to select the polarity of the synchronization input pin.

- 0: Falling edge only
- 1: Rising edge and high level

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#### Bit 2 AM: Acquisition mode

This bit is set and cleared by software to select the acquisition mode.

- 0: Normal acquisition mode (acquisition starts as soon as START bit is set)
- 1: Synchronized acquisition mode (acquisition starts if START bit is set and when the selected signal is detected on the SYNC input pin)

Note: This bit must not be modified when an acquisition is ongoing.

#### Bit 1 START: Start a new acquisition

This bit is set by software to start a new acquisition. It is cleared by hardware as soon as the acquisition is complete or by software to cancel the ongoing acquisition.

- 0: Acquisition not started
- 1: Start a new acquisition

### Bit 0 TSCE: Touch sensing controller enable

This bit is set and cleared by software to enable/disable the touch sensing controller.

- 0: Touch sensing controller disabled
- 1: Touch sensing controller enabled

Note: When the touch sensing controller is disabled, TSC registers settings have no effect.

# 17.6.2 TSC interrupt enable register (TSC\_IER)

Address offset: 0x04

Reset value: 0x0000 0000

31	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16
Res.	Res.														
15	14	13	12	11	10	0	0	7	6	F	4	2	_		_
13	14	13	12	- 11	10	9	8	1	6	5	4	3	2	1	U
Res.	MCEIE	EOAIE													

Bits 31:2 Reserved, must be kept at reset value.

### Bit 1 MCEIE: Max count error interrupt enable

This bit is set and cleared by software to enable/disable the max count error interrupt.

- 0: Max count error interrupt disabled
- 1: Max count error interrupt enabled

### Bit 0 **EOAIE**: End of acquisition interrupt enable

This bit is set and cleared by software to enable/disable the end of acquisition interrupt.

- 0: End of acquisition interrupt disabled
- 1: End of acquisition interrupt enabled

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# 17.6.3 TSC interrupt clear register (TSC\_ICR)

Address offset: 0x08

Reset value: 0x0000 0000

31	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16
Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
15 Res.	14 Res.	13 Res.	12 Res.	11 Res.	10 Res.	9 Res.	8 Res.	7 Res.	6 Res.	5 Res.	4 Res.	Res.	2 Res.	1 MCEIC	0 EOAIC

Bits 31:2 Reserved, must be kept at reset value.

#### Bit 1 MCEIC: Max count error interrupt clear

This bit is set by software to clear the max count error flag and it is cleared by hardware when the flag is reset. Writing a '0' has no effect.

0: No effect

1: Clears the corresponding MCEF of the TSC\_ISR register

### Bit 0 **EOAIC**: End of acquisition interrupt clear

This bit is set by software to clear the end of acquisition flag and it is cleared by hardware when the flag is reset. Writing a '0' has no effect.

0: No effect

1: Clears the corresponding EOAF of the TSC\_ISR register



# 17.6.4 TSC interrupt status register (TSC\_ISR)

Address offset: 0x0C

Reset value: 0x0000 0000

31	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16
Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
15 Res.	14 Res.	13 Res.	12 Res.	11 Res.	10 Res.	9 Res.	8 Res.	7 Res.	6 Res.	5 Res.	4 Res.	3 Res.	2 Res.	1 MCEF	0 EOAF

Bits 31:2 Reserved, must be kept at reset value.

#### Bit 1 MCEF: Max count error flag

This bit is set by hardware as soon as an analog I/O group counter reaches the max count value specified. It is cleared by software writing 1 to the bit MCEIC of the TSC ICR register.

- 0: No max count error (MCE) detected
- 1: Max count error (MCE) detected

### Bit 0 EOAF: End of acquisition flag

This bit is set by hardware when the acquisition of all enabled group is complete (all GxS bits of all enabled analog I/O groups are set or when a max count error is detected). It is cleared by software writing 1 to the bit EOAIC of the TSC ICR register.

- 0: Acquisition is ongoing or not started
- 1: Acquisition is complete

# 17.6.5 TSC I/O hysteresis control register (TSC\_IOHCR)

Address offset: 0x10

Reset value: 0xFFFF FFFF

31	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16
Res.	G6_IO4	Res.G6 _IO3	G6_IO2	G6_IO1	G5_IO4	G5_IO3	G5_IO2	G5_IO1							
								rw	rw	rw	rw	rw	rw	rw	rw
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
G4_IO4	G4_IO3	G4_IO2	G4_IO1	G3_IO4	G3_IO3	G3_IO2	G3_IO1	G2_IO4	G2_IO3	G2_IO2	G2_IO1	G1_IO4	G1_IO3	G1_IO2	G1_IO1
rw	rw	rw	rw	rw	rw	rw									

Bits 31:24 Reserved, must be kept at reset value.

Bits 23:0 Gx\_IOy: Gx\_IOy Schmitt trigger hysteresis mode

These bits are set and cleared by software to enable/disable the Gx\_IOy Schmitt trigger hysteresis.

- 0: Gx\_IOy Schmitt trigger hysteresis disabled
- 1: Gx\_IOy Schmitt trigger hysteresis enabled

Note: These bits control the I/O Schmitt trigger hysteresis whatever the I/O control mode is (even if controlled by standard GPIO registers).

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#### 17.6.6 TSC I/O analog switch control register (TSC\_IOASCR)

Address offset: 0x18

Reset value: 0x0000 0000

31	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16
Res.	G6_IO4	G6_IO3	G6_IO2	G6_IO1	G5_IO4	G5_IO3	G5_IO2	G5_IO1							
								rw	rw	rw	rw	rw	rw	rw	rw
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
								7 G2_IO4	_			3 G1_IO4	2 G1_IO3	1 G1_IO2	0 G1_IO1

Bits 31:24 Reserved, must be kept at reset value.

Bits 23:0 **Gx\_IOy**: Gx\_IOy analog switch enable

These bits are set and cleared by software to enable/disable the Gx\_IOy analog switch.

0: Gx IOy analog switch disabled (opened)

1: Gx\_IOy analog switch enabled (closed)

Note: These bits control the I/O analog switch whatever the I/O control mode is (even if controlled by standard GPIO registers).

#### 17.6.7 TSC I/O sampling control register (TSC\_IOSCR)

Address offset: 0x20

Reset value: 0x0000 0000

31	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16
Res.	G6_IO4	G6_IO3	G6_IO2	G6_IO1	G5_IO4	G5_IO3	G5_IO2	G5_IO1							
								rw							
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
G4_IO4	G4_IO3	G4_IO2	G4_IO1	G3_IO4	G3_IO3	G3_IO2	G3_IO1	G2_IO4	G2_IO3	G2_IO2	G2_IO1	G1_IO4	G1_IO3	G1_IO2	G1_IO1
rw															

Bits 31:24 Reserved, must be kept at reset value.

Bits 23:0 Gx\_IOy: Gx\_IOy sampling mode

These bits are set and cleared by software to configure the Gx IOy as a sampling capacitor I/O. Only one I/O per analog I/O group must be defined as sampling capacitor.

0: Gx\_IOy unused

1: Gx\_IOy used as sampling capacitor

Note: These bits must not be modified when an acquisition is ongoing.

During the acquisition phase and even if the TSC peripheral alternate function is not enabled, as soon as the TSC\_IOSCR bit is set, the corresponding GPIO analog switch is automatically controlled by the touch sensing controller.

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# 17.6.8 TSC I/O channel control register (TSC\_IOCCR)

Address offset: 0x28

Reset value: 0x0000 0000

31	30	29	28	27	26	26 25		23	22	21	20	19	18	17	16
Res.	G6_IO4	G6_IO3	G6_IO2	G6_IO1	G5_IO4	G5_IO3	G5_IO2	G5_IO1							
								rw							
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
G4_IO4	G4_IO3	G4_IO2	G4_IO1	G3_IO4	G3_IO3	G3_IO2	G3_IO1	G2_IO4	G2_IO3	G2_IO2	G2_IO1	G1_IO4	G1_IO3	G1_IO2	G1_IO1

Bits 31:24 Reserved, must be kept at reset value.

Bits 23:0 Gx\_IOy: Gx\_IOy channel mode

These bits are set and cleared by software to configure the Gx\_IOy as a channel I/O.

0: Gx IOy unused

1: Gx\_IOy used as channel

Note: These bits must not be modified when an acquisition is ongoing.

During the acquisition phase and even if the TSC peripheral alternate function is not enabled, as soon as the TSC\_IOCCR bit is set, the corresponding GPIO analog switch is automatically controlled by the touch sensing controller.

# 17.6.9 TSC I/O group control status register (TSC\_IOGCSR)

Address offset: 0x30

Reset value: 0x0000 0000

31	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16
Res.	G6S	G5S	G4S	G3S	G2S	G1S									
										r	r	r	r	r	r
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Res.	G6E	G5E	G4E	G3E	G2E	G1E									

Bits 31:22 Reserved, must be kept at reset value.

#### Bits 21:16 GxS: Analog I/O group x status

These bits are set by hardware when the acquisition on the corresponding enabled analog I/O group x is complete. They are cleared by hardware when a new acquisition is started.

- 0: Acquisition on analog I/O group x is ongoing or not started
- 1: Acquisition on analog I/O group x is complete

Note: When a max count error is detected the remaining GxS bits of the enabled analog I/O groups are not set.

Bits 15:6 Reserved, must be kept at reset value.

### Bits 5:0 GxE: Analog I/O group x enable

These bits are set and cleared by software to enable/disable the acquisition (counter is counting) on the corresponding analog I/O group x.

- 0: Acquisition on analog I/O group x disabled
- 1: Acquisition on analog I/O group x enabled



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# 17.6.10 TSC I/O group x counter register (TSC\_IOGxCR)

x represents the analog I/O group number. Address offset: 0x30 + 0x04 \* x, (x = 1..6)

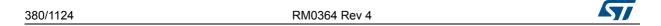
Reset value: 0x0000 0000

31	30	29	28	27	26	25	24	23	22	21	20	19	18	17	16
Res.	Res.	Res.	Res.	Res.	Res.	Res.									
15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Res.	Res.							CNT	[13:0]						
		r	r	r	r	r	r	r	r	r	r	r	r	r	r

Bits 31:14 Reserved, must be kept at reset value.

Bits 13:0 CNT[13:0]: Counter value

These bits represent the number of charge transfer cycles generated on the analog I/O group x to complete its acquisition (voltage across  $C_S$  has reached the threshold).



# 17.6.11 TSC register map

Table 65. TSC register map and reset values

	Table 65. TSC register map and re													16:	bet	VC	ııu	<b>C</b> 3															
Offset	Register	31	30	53	28	27	26	25	74	23	22	17	20	19	18	17	16	15	14	13	12	11	10	6	8	7	9	2	4	ဗ	2	l	0
0x0000	TSC_CR	CTPH[3:0]				C	CTPL[3:0]		0]	SS			6]D	5:0]			SSE	SSPSC	SSPSC			Res.	Res.	Res.	Res.		MC\ [2:0		IODEF	SYNCPOL	AM	START	TSCE
	Reset value	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0					0	0	0	0	0	0	0	0
0x0004	TSC_IER	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	MCEIE	EOAIE
	Reset value																															0	0
0x0008	TSC_ICR	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	MCEIC	EOAIC
	Reset value																															0	0
0x000C	TSC_ISR	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	MCEF	EOAF
	Reset value									_				_												_				_		0	0
0x0010	TSC_IOHCR	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	G6_104	66_103	66_102	G6_101	G5_I04	65_103	G5_102	G5_IO1	G4_I04	64_103	64_102	G4_I01	63_104	69_103	63_102	63_101	G2_I04	62_103	G2_102	G2_I01	G1_104	61_103	61_102	61_101
	Reset value									1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1
0x0014	014 Reserved																																
0x0018	TSC_IOASCR	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	G6_104	66_103	G6_102	G6_101	G5_I04	65_103	G5_102	G5_I01	G4_I04	G4_103	G4_102	G4_I01	G3_I04	63_103		63_101	G2_104	G2_103	G2_102	G2_I01	G1_104	G1_103	G1_102	G1_I01
	Reset value										0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
0x001C		1											1		serv																		
0x0020	TSC_IOSCR	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	G6_104	66_103	G6_102	G6_101	G5_104	65_103	G5_102	G5_101	G4_I04	G4_IO3	G4_102	G4_I01	63_104	63_103	63_102	63_101	G2_I04	62_103	G2_I02	G2_I01	G1_I04	G1_I03	G1_102	G1_I01
	Reset value									0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
0x0024		1											1		serv																		
0x0028	TSC_IOCCR	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	G6_104	66_103	G6_102	G6_101	G5_I04	65_103	G5_IO2	G5_I01	G4_IO4	64_103		G4_I01	63_104		G3_102	63_101	G2_I04	G2_IO3	G2_I02	G2_I01	G1_I04	G1_IO3	G1_I02	G1_I01
	Reset value									0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
0x002C														Re	serv	/ed																	
0x0030	TSC_IOGCSR	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	S95	G5S	G4S	G3S	G2S	G1S	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	G6E	GSE	G4E	G3E	G2E	G1E
	Reset value											0	0	0	0	0	0											0	0	0	0	0	0
0x0034	TSC_IOG1CR	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.						C	TN	[13:						
	Reset value																			0	0	0	0	0	0	0	0	0	0	0	0	0	0
0x0038	TSC_IOG2CR	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.						C	NT	[13:	0]					
	Reset value																			0	0	0	0	0	0	0	0	0	0	0	0	0	0



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Table 65. TSC register map and reset values (continued)

													_								-			_	ė		_			_			
Offset	Register	31	30	29	28	27	26	22	24	23	22	21	20	19	18	17	16	15	14	13	12	11	10	6	8	7	9	2	4	3	7	7	0
0x003C	TSC_IOG3CR	\$\frac{1}{2}\$ \frac{1}{2}\$ \fra																															
	Reset value																			0	0	0	0	0	0	0	0	0	0	0	0	0	0
0x0040	TSC_IOG4CR	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	CNT[13:0]													
	Reset value																			0	0	0	0	0	0	0	0	0	0	0	0	0	0
0x0044	TSC_IOG5CR	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.						С	NT	[13:	0]					
	Reset value																			0	0	0	0	0	0	0	0	0	0	0	0	0	0
0x0048	TSC_IOG6CR	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	Res.	CNT[13:0]													
	Reset value																			0	0	0	0	0	0	0	0	0	0	0	0	0	0

Refer to Section 2.2 on page 47 for the register boundary addresses.

